

SAMPLE

検査成績表
<TEST REPORT>HIOKI
HIOKI E.E. CORPORATION

1/1

品名<Model Name> (高分解能ユニット<HIGH RESOLUTION UNIT>)
形名<Model Number> (8957)
製造番号<Serial No.> (No. 110225670)
検査年月日<Test Date> (2011-02-18)
(<YYYY-MM-DD>)
検査条件<Test Conditions> (22.5 °C, 49 %rh)

項目 <Item>	レンジ <Range>	検査点 <Test Point>	許容範囲 <Tolerance>	測定値 <Measured Value>
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1.ゼロポジション確度<Zero Position Accuracy>

100 mV/DIV ゼロ調整後 -0.0020000 V ~ 0.0020000 V (CH1 0.0000625 V) (CH2 0.0000000 V)
*1 <After Zero Adjustment>

2.DC振幅確度<DC Amplitude Accuracy>

			CH1	CH2
5 mV/DIV	100 mV	99.800000 mV ~ 100.200000 mV	(100.021875 mV)	(100.012500 mV)
10 mV/DIV	200 mV	199.600000 mV ~ 200.400000 mV	(200.00625 mV)	(199.99375 mV)
20 mV/DIV	400 mV	399.200000 mV ~ 400.800000 mV	(399.9875 mV)	(400.00000 mV)
50 mV/DIV	1 V	0.99800000 V ~ 1.00200000 V	(1.00025000 V)	(1.00018750 V)
100 mV/DIV	2 V	1.99600000 V ~ 2.00400000 V	(2.0003125 V)	(2.0003750 V)
200 mV/DIV	4 V	3.99200000 V ~ 4.00800000 V	(4.000500 V)	(4.000750 V)
500 mV/DIV	10 V	9.98000000 V ~ 10.02000000 V	(10.0046875 V)	(9.9993750 V)
1 V/DIV	20 V	19.96000000 V ~ 20.04000000 V	(20.001250 V)	(19.996250 V)
2 V/DIV	40 V	39.92000000 V ~ 40.08000000 V	(39.99625 V)	(39.99250 V)
5 V/DIV	100 V	99.80000000 V ~ 100.20000000 V	(100.012500 V)	(100.000000 V)
10 V/DIV	200 V	199.60000000 V ~ 200.40000000 V	(200.01250 V)	(200.00625 V)
20 V/DIV	400 V	399.20000000 V ~ 400.80000000 V	(400.0125 V)	(400.0125 V)

備考<Note>

*1 ゼロポジション確度は、入力結合(カップリング)GNDにて校正しています。入力結合(カップリング)GNDとは内部回路で入力とGNDを短絡することです。<The accuracy of the zero position is calibrated by coupling GND. Coupling GND means to short input and GND at the inner circuit.>

FAIL判定箇所は、グレー表示としています。<FAIL decision points are highlighted in gray.>

総合判定<Overall Result>	検査者<Inspected by>	承認者<Approved by>
(PASS)	()	()